ISS	ue C	iassit	ication	

Application/Control No. 10/829,373	Applicant(s)/Patent under Reexamination YAMAOKA ET AL.
Examiner	Art Unit
Hai H. Huynh	3747

				ISSUE	CL	.AS	SIF	ICATI	ON						
		ORIGINAL						INT	ERNATIONA	AL CLAS	SIFICA	TION			
	CLASS		SUBCL	SS CLAIMED				NON-CLAIN							
	123		295	5	F	02	В	17	/00	G	06	F	19 /00		
	CROS	S REFEREN	NCES						,					,	
CLASS	SUBCLA	SS (ONE SU	JBCLASS PER	BLOCK)									1		
123	90.11	90.15	568.14	435					1				/		
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(Assistant Examiner) (Date)				Hai Huynh //10/06			Total Claims Allowed: 16  O.G. O.G.								
(Legal Instruments Examiner) (Date)			(Primary Examiner) (Date)				Print Claim(s)					Print Fig			

Claims ren	umbered in the sa	me order as p	resented by	applicant	☐ CF	PA	ПΤ	.D.		R.1.47
Final	Final	Final	Final	Original	Final	Original	Final	Original	Final	Original
00	31	61		91		121		151	·	181
2	32	62		92		122		152	-	182
2 3	33	63		93		123		153		183
3 4	34	64		94		124		154		184
(4) (5)	35	65	4 N	95		125		155		185
5 6	36	66		96		126		156		186
6 7	37	67		97		127		157		187
7 8	38	68		98		128		158		188
8 9	39	69		99		129		159		189
9 10	40	70		100		130		160		190
10 11	41	71		101		131		161		191
12 12	42	72		102		132		162		192
11 13	43	73		103		133		163		193
13 14	44	74		104		134		164		194
14 15	45	75		105		135		165		195
15 16	46	76		106		136		166		196
16 17	47	77		107		137		167		197
18	48	78		108		138		168		198
19	49	79		109		139		169		199
20	50	80		110		140		170		200
21	51	81		111		141		171		201
22	52	82		112		142		172		202
23	53	83		113		143		173		203
24	54	84		114		144		174		204
25	55	85		115		145		175		205
26	56	86		116		146		176		206
27	57	87		117		147		177		207
28	58	88		118		148		178		208
29	59	89		119		149		179		209
30	60	90		120		150		180		210